

Centre Testing International (Shenzhen) Corporation

Test Lab
Attestation Letter

Date of Test:

May 26, 2016 to Jun. 15, 2016

Applicant Name:

Sen.se

FCC ID:

2ABGNPEA001

Test Items:

Conducted Peak Output Power, 6dB Occupied Bandwidth, Power Spectral Density, Band-edge for RF Conducted Emissions, RF Conducted Spurious Emissions, Radiated Spurious Emissions, Restricted bands around fundamental frequency (Radiated Emission)

**Name of Engineer
Performing Test:**

Kevin lan

Statement of Compliance:

Centre Testing International (Shenzhen) Corporation declares that this Unit has been tested in accordance with the test method identified in this test report and that we observed it being tested. It also declares that the Unit complies with the relevant limits. All instrumentation and accessories used to test this unit for compliance to the indicated test method are calibrated regularly in accordance with ISO 17025:2005 requirements by laboratories accredited by A2LA, NVLAP, or ACLAS for the measurement parameters.

**The measurements were made
at:**

Centre Testing International (Shenzhen) Corporation
Hongwei Industrial Zone, Bao'an 70 District, Shenzhen, Guangdong,
China518101

Test Lab Witness-

Signature of Test Lab Witness:

Sheek Luo

Full Name, Typed:

Sheek Luo

Title of Witness:

Lab supervisor

Email Address:

sheek.luo@cti-cert.com

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